

Features

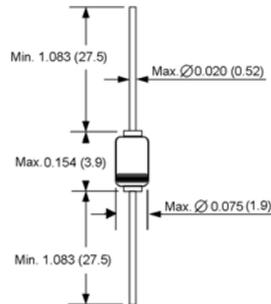
- ◆ Silicon Epitaxial Planar Diode
- ◆ Fast switching diode
- ◆ This diode is also available in other case styles including the MiniMELF case with the type designation LL4148, and the DO-34 case with type designation 1N4148S.



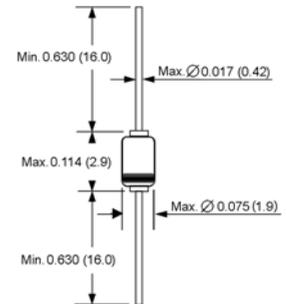
Mechanical Data

- ◆ Case: DO-34, DO-35 Glass Case
- ◆ Weight: approx. 0.13g

DO-204AH (DO-35 Glass)



DO-34 Glass



Maximum Ratings and Thermal Characteristics

($T_A=25^\circ\text{C}$ unless otherwise noted.)

| Parameter | Symbol | Limit | Unit |
|--|-----------------|--------------------|---------------------------|
| Reverse voltage | V_R | 75 | Volts |
| Peak reverse voltage | V_{RM} | 100 | Volts |
| Average rectified current half wave rectification with resistive load at $T_{amb}=25^\circ\text{C}$ | $I_{F(AV)}$ | 150 ⁽¹⁾ | mA |
| Surge forward current at $t<1\text{s}$ and $T_J=25^\circ\text{C}$ | I_{FSM} | 500 | mA |
| Power dissipation at $T_{amb}=25^\circ\text{C}$ ⁽¹⁾ | P_{tot} | 500 | mW |
| Thermal resistance junction to ambient air ⁽¹⁾ | $R_{\theta JA}$ | 350 | $^\circ\text{C}/\text{W}$ |
| Junction temperature | T_J | 175 | $^\circ\text{C}$ |
| Storage temperature range | T_S | -65 to +175 | $^\circ\text{C}$ |

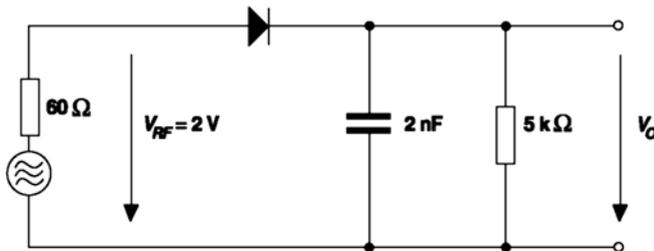
Notes: 1. Valid provided that leads at a distance of 8mm from case are kept at ambient temperature

Electrical Characteristics

($T_j=25^\circ\text{C}$ unless otherwise noted.)

| Parameter | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|---|-------------|---|------|------|-----------------|--------------------------------------|
| Reverse breakdown voltage | $V_{(BR)R}$ | $I_R=100\mu\text{A}$ | 100 | | | Volts |
| Forward voltage | V_F | $I_F=10\text{mA}$ | - | - | 1.0 | Volt |
| Leakage current | I_R | $V_R=20\text{V}$ $V_R=75\text{V}$ $V_R=20\text{V}, T_j=150^\circ\text{C}$ | - | - | 25 5.0 50 | nA μA μA |
| Capacitance | C_{tot} | $V_F=V_R=0\text{V}$ | - | - | 4.0 | pF |
| Voltage rise when switching ON (tested with 50mA pulses) | V_{fr} | $t_p = 0.1\text{s}$, Rise time < 30ns $f_p=5$ to 100kHz | - | - | 2.5 | ns |
| Reverse recovery time | t_{rr} | $I_F=10\text{mA}$, $I_R=1\text{mA}$ $V_R=6\text{V}$, $R_L=100\Omega$ | - | - | 4.0 | ns |
| Rectification efficiency | η_V | $f=100\text{MHz}$, $V_{RF}=2\text{V}$ | 0.45 | - | - | - |

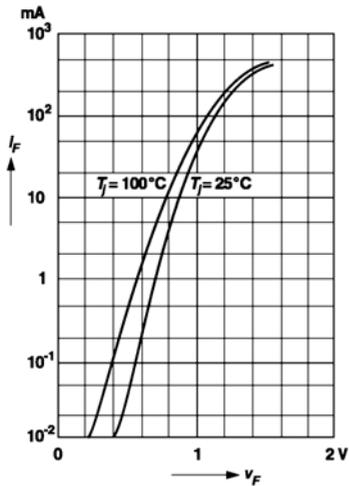
Rectification Efficiency Measurement Circuit



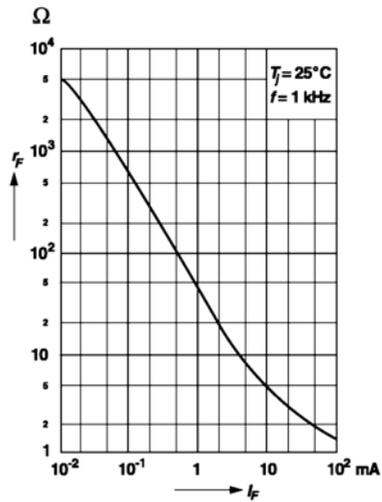
RATINGS AND CHARACTERISTIC CURVES

($T_A = 25^\circ\text{C}$ unless otherwise noted)

Forward characteristics

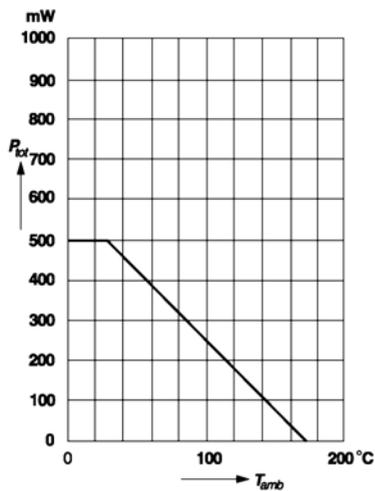


Dynamic forward resistance versus forward current

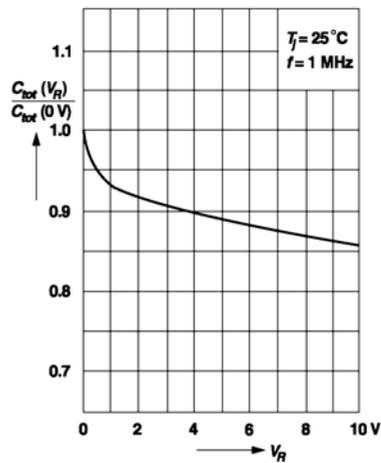


Admissible power dissipation versus ambient temperature

For conditions, see footnote in table "Absolute Maximum Ratings"



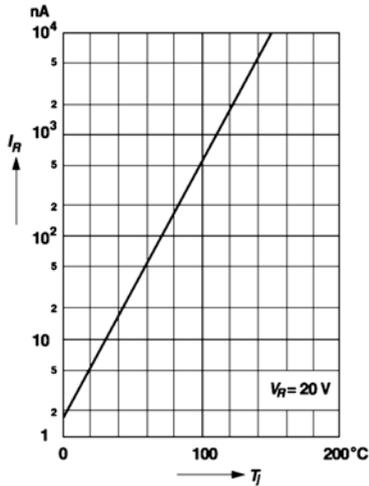
Relative capacitance versus reverse voltage



RATINGS AND CHARACTERISTIC CURVES

($T_A = 25^\circ\text{C}$ unless otherwise noted)

Leakage current
versus junction temperature



Admissible repetitive peak forward current versus pulse duration

For conditions, see footnote in table "Absolute Maximum Ratings"

